

18th International **Zurich Symposium** on Electromagnetic Compatibility

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Technical Exhibition on EMC and RF/Microwave Measurements & Instrumentation

EMC Zurich in Munich 2007 September 24-28 Technische Universität München, Germany



The 18th International Zurich Symposium & Technical Exhibition on Electromagnetic Compatibility will be held at the Technische Universität München, Germany, from Monday, September 24, through Friday, September 28, 2007.

Munich has been selected to host EMC Zurich not only because of its attractive location but also because of its excellent business climate, fabulous facilities and worldclass universities. Munich is a vibrant city with a rich culture and traditions. Incidentally, the world-renowned Oktoberfest coincides with EMC Zurich 2007.

So come and join EMC Zurich in Munich in 2007. We will follow our tradition of a rich scientific program of highest quality with invited speakers from all over the world. As in the past, we will provide a broad forum of exchange for both academia and industry alike.

The symposium will cover the entire scope of electromagnetic compatibility. Prospective authors are invited to submit original papers on their latest research results. We also solicit proposals for topical meetings, workshops and tutorials.

Important Dates

Proposals for workshops, tutorials and topical meetings October 6, 2006

Preliminary paper submissions for regular sessions (4 pages in PDF format only) **February 2, 2007**

Notification of acceptance

April 13, 2007

Final paper submission

June 8, 2007

All submissions must be electronic. No hardcopies shall be accepted. Details on the symposium website:

www.emc-zurich.ch

General Chairman

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Symposium Topics

- EMC Management
- EMC Measurement Techniques
- EMC Testing
- Standards & Regulations
- EM Environment
- Power System EMC
- Lightning
- System-Level EMC
- EMC in Electronic Packaging
- IC Chip EMC

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Authors are requested to submit a preliminary paper up to four pages in length, including title, author's affiliation, abstract, figures and references.

One additional page should contain the paper's title, authors' affiliation, name of the correspondence author, his/her address, telephone/fax number and e-mail address. On the same page, you should clearly summarize the novelty of your contribution and indicate the desired technical areas (maximum of two). The submission must be in electronic format (PDF or Word). A Word template is available on the symposium website. No hard-copies shall be accepted.

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Submissions will be reviewed by the Technical Program Committee based on originality and novelty, quality, technical sophistication/depth and importance of topic.

Student Paper Prize

Papers considered for the Student Paper Prize are expected to be predominantly the work of the student. Papers co-authored by a student and his/her advisor are eligible, provided the student is the principal author and also the presenter. Please indicate in your electronic submission if you want to be considered for the Student Paper Prize.

- PCB EMC
- Signal Integrity
- EMC Innovation
- EMC Protection
- EMC in Wireless Communications
- Automotive EMC
- Computational Electromagnetics
- Bio-Medical EMC
- Electromagnetic Product Safety
- EMC in Nanoelectronics

Accepted Papers

Notifications of paper acceptance and the necessary information to electronically submit the final version of the paper will be sent to the authors no later than April 20, 2007. Final papers must not exceed four pages, including figures, tables and references.

Exhibitio

The Technical Exhibition on EMC and RF/Microwave Measurements and Instrumentation will be the major accompanying event of EMC Zurich in Munich in 2007. The Technical Exhibition is a must-attend for all major manufacturers and distributors of EMC-related equipment and tools, such as: measurement and EMC test systems, protecting devices and components, RF/microwave instrumentation, electromagnetics analysis/synthesis software, etc

Further information can be obtained from:

Exhibition Organizer



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